## Notice of References Cited Application/Control No. 10/536,732 Examiner IZUNNA OKEKE Applicant(s)/Patent Under Reexamination DESMICHT ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,826,007	10-1998	Sakaki et al.	714/42
*	В	US-2005/0033951	02-2005	Madter et al.	713/002
*	C	US-6,118,870	09-2000	Boyle et al.	380/201
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Η	US-			
	_	US-			
	7	US-			
	K	US-			
	L_	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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